

**Search Notes**

Application/Control No.

09/741,631

Examiner

Ted M. Wang

Applicant(s)/Patent under  
Reexamination

PATRICK, CHRISTOPHER

Art Unit

2611

**SEARCHED**

Class	Subclass	Date	Examiner
375	343	11/1/2007	TW
701	207	11/1/2007	TW
	UPDATED		
375	141, 150	11/1/2007	TW
342	378	11/1/2007	TW

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner
375	141, 150	11/1/2007	TW
375	343	11/1/2007	TW
342	378	11/1/2007	TW
701/207		11/1/2007	TW

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
EAST - USPGPUB, USPAT, USOCR, EPO, JPO, DERWENT, IBM_TDB, see attached search report	11/1/2007	TW
ODP- searched and reviewed.	11/1/2007	TW
Inventor search - Patrick with Christopher	11/1/2007	TW
IEEEExplor - author search - Patrick C.	11/1/2007	TW